

## **Excellent Integrated System Limited**

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Vishay/Siliconix SIS776DN-T1-GE3

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HALOGEN

Vishay Siliconix

## N-Channel 30 V (D-S) MOSFET with Schottky Diode

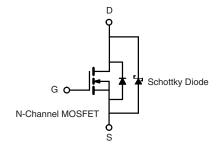
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>e</sup>	Q <sub>g</sub> (Typ.)			
30	0.0062 at V <sub>GS</sub> = 10 V	35	11.6 nC			
30	$0.0087$ at $V_{GS} = 4.5 \text{ V}$	35	11.0110			

#### **FEATURES**

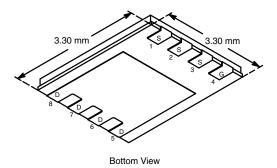
- Halogen-free According to IEC 61249-2-21 **Definition**
- SkyFET Monolithic TrenchFET® Power MOSFET and Schottky Diode
- Low Thermal Resistance PowerPAK® FREE Package with Small Size and Low 1.07 mm Profile
- 100 % R<sub>q</sub> Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

System Power - Low Side







Ordering Information: SiS776DN-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	30	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	v		
	T <sub>C</sub> = 25 °C		35 <sup>e</sup>		
Continuous Drain Current /T 150 °C)	T <sub>C</sub> = 70 °C		35 <sup>e</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	18.3 <sup>a, b</sup>		
	T <sub>A</sub> = 70 °C		14.5 <sup>a, b</sup>		
Pulsed Drain Current		I <sub>DM</sub>	60	Α	
Continuous Course Prain Diode Current	T <sub>C</sub> = 25 °C	1	35 <sup>e</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	ls	5.4 <sup>a, b</sup>		
Single Pulse Avalanche Current	1 0.1 ml l	I <sub>AS</sub>	20		
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	20	mJ	
	T <sub>C</sub> = 25 °C		52		
Manipular Davida Dispiration	T <sub>C</sub> = 70 °C	D	33	١,,,	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.8 <sup>a, b</sup>	W	
	T <sub>A</sub> = 70 °C		2.4 <sup>a, b</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>c, d</sup>			260		

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- c. See solder profile (www.vishay.com/ppg?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Package limited.

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Datasheet of SIS776DN-T1-GE3 - MOSFET N-CH 30V 35A 1212-8

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THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>a, b</sup>	t ≤ 10 s	R <sub>thJA</sub>	24	33	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	1.9	2.4	C/VV		

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 81  $^{\circ}\text{C/W}.$

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	30			V	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.0		2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	_	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	0.030		0.30	m A	
	I <sub>DSS</sub>	$V_{DS}$ = 30 V, $V_{GS}$ = 0 V, $T_J$ = 100 °C		1.6	15	mA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain-Source On-State Resistance <sup>a</sup>	В	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		0.0050	0.0062	Ω	
	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$		0.0072	0.0087		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 10 A		40		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			1360		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		340			
Reverse Transfer Capacitance	C <sub>rss</sub>			117			
Total Gate Charge	Q <sub>g</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		24	36		
Total Gate Charge				11.6	17.5	nC	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		3.5			
Gate-Drain Charge	Q <sub>gd</sub>			3.6			
Gate Resistance	$R_g$	f = 1 MHz	0.4	1.5	3.0	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			18	35		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.5 $\Omega$		11	22	] 	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		20	40		
Fall Time	t <sub>f</sub>			10	20		
Turn-On Delay Time	t <sub>d(on)</sub>			11	22	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		10	20	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		20	40		
Fall Time	t <sub>f</sub>			8	16		



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<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			35	А		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				60	A		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 3 A		0.49	0.65	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			19	35	ns		
Body Diode Reverse Recovery Charge	$Q_{rr}$	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>I</sub> = 25 °C		8	15	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	1 1 - 10 Λ, αι/αι - 100 Λ/μο, 1 J - 20 0		8		ns		
Reverse Recovery Rise Time	t <sub>b</sub>			11		110		

#### Notes:

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

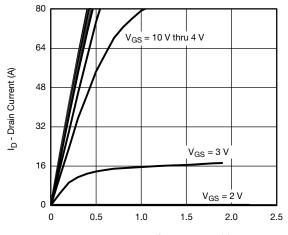
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



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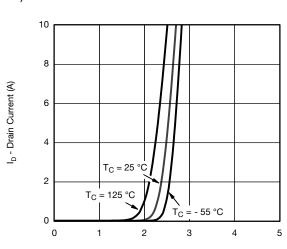
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#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

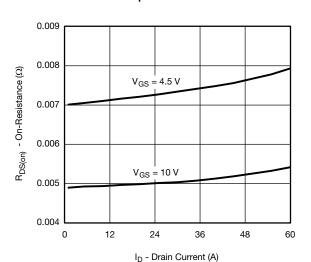


V<sub>DS</sub> - Drain-to-Source Voltage (V)

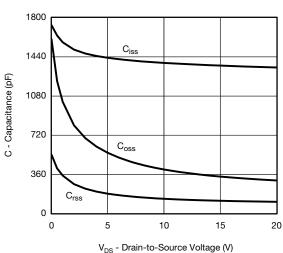
Output Characteristics



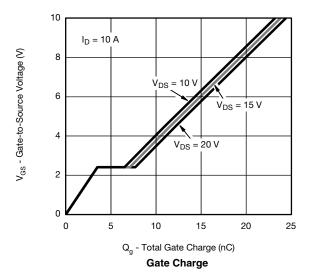
V<sub>GS</sub> - Gate-to-Source Voltage (V) **Transfer Characteristics** 

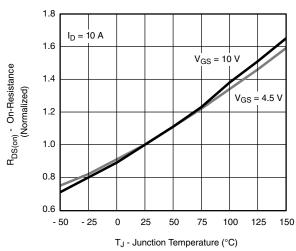


On-Resistance vs. Drain Current



Capacitance





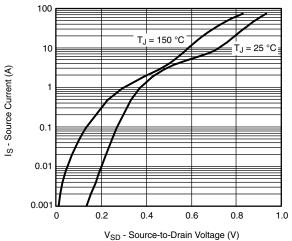
On-Resistance vs. Junction Temperature



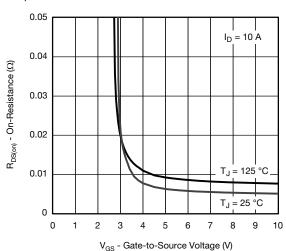


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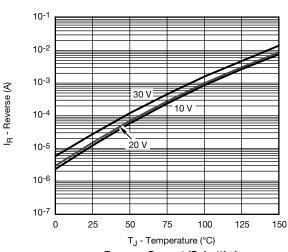
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



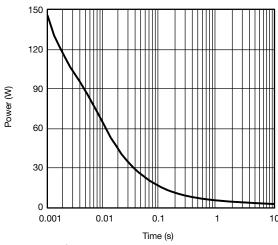
Source-Drain Diode Forward Voltage



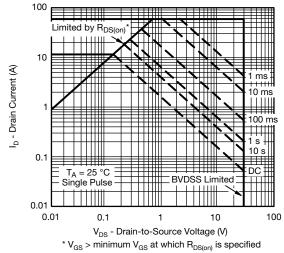
On-Resistance vs. Gate-to-Source Voltage



**Reverse Current (Schottky)** 



Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

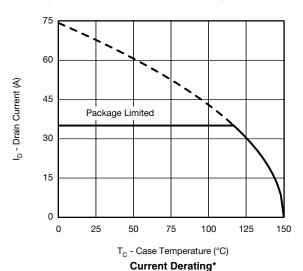
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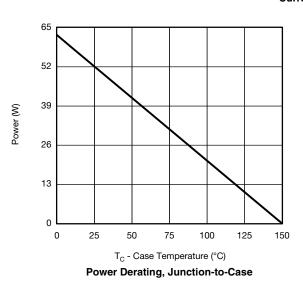


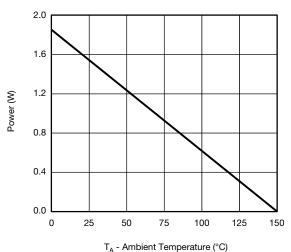
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#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)









Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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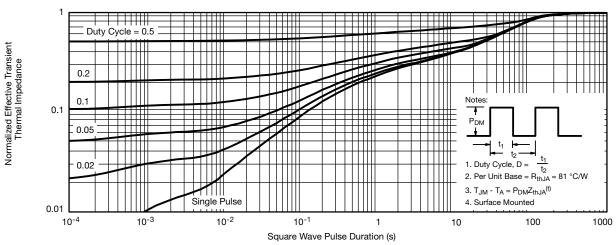
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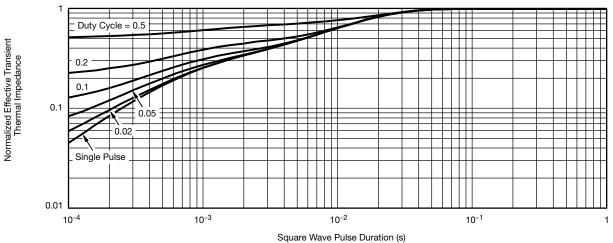
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#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?67012">www.vishay.com/ppg?67012</a>.

Document Number: 67012 S10-2251-Rev. A, 04-Oct-10



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